BB405M

Build in Biasing Circuit MOS FET IC
UHF/VHF RF Amplifier

HITACHI

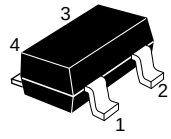
ADE-208-718A (Z)
2nd. Edition
Dec. 1998

Features

- Build in Biasing Circuit; To reduce using parts cost & PC board space.
- Superior cross modulation characteristics.
- High gain;
  (PG = 28 dB typ. at f = 200 MHz)
- Wide supply voltage range;
  Applicable with 5V to 9V supply voltage.
- Withstanding to ESD;
  Build in ESD absorbing diode. Withstand up to 200V at C=200pF, Rs=0 conditions.
- Provide mini mold packages; MPAK-4R(SOT-143 var.)

Outline

MPAK-4R



1. Source
2. Drain
3. Gate2
4. Gate1

Notes: 1. Marking is “EX–”.
2. BB405M is individual type number of HITACHI BBFET.

Hitachi semiconductor

Absolute Maximum Ratings (Ta = 25°C)

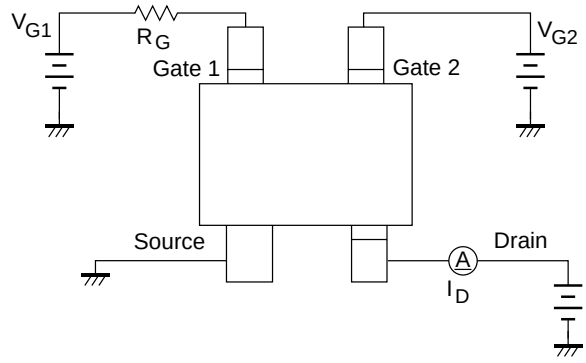
Item	Symbol	Ratings	Unit
Drain to source voltage	V_{DS}	12	V
Gate1 to source voltage	V_{G1S}	+10 – 0	V
Gate2 to source voltage	V_{G2S}	±10	V
Drain current	I_D	25	mA
Channel power dissipation	Pch	150	mW
Channel temperature	Tch	150	°C
Storage temperature	Tstg	–55 to +150	°C

Electrical Characteristics (Ta = 25°C)

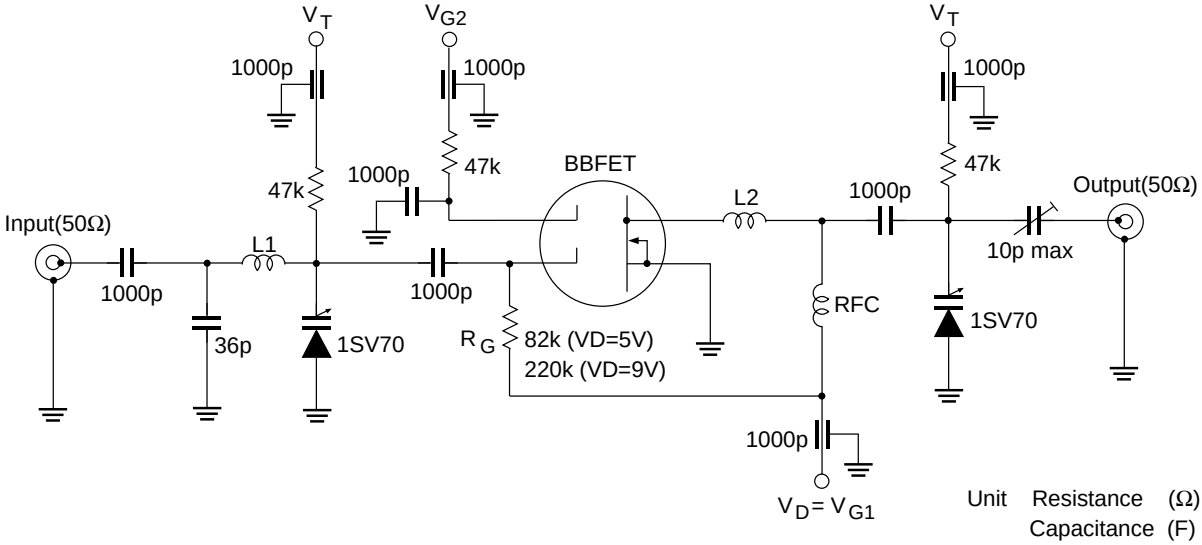
Item	Symbol	Min	Typ	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	12	—	—	V	I_D = 200µA, V_{G1S} = V_{G2S} = 0
Gate1 to source breakdown voltage	$V_{(BR)G1SS}$	+10	—	—	V	I_{G1} = +10µA, V_{G2S} = V_{DS} = 0
Gate2 to source breakdown voltage	$V_{(BR)G2SS}$	±10	—	—	V	I_{G2} = ±10µA, V_{G1S} = V_{DS} = 0
Gate1 to source cutoff current	I_{G1SS}	—	—	+100	nA	V_{G1S} = +9V, V_{G2S} = V_{DS} = 0
Gate2 to source cutoff current	I_{G2SS}	—	—	±100	nA	V_{G2S} = ±9V, V_{G1S} = V_{DS} = 0
Gate1 to source cutoff voltage	$V_{G1S(off)}$	0.4	0.7	1.0	V	V_{DS} = 5V, V_{G2S} = 4V, I_D = 100µA
Gate2 to source cutoff voltage	$V_{G2S(off)}$	0.4	0.7	1.0	V	V_{DS} = 5V, V_{G1S} = 5V, I_D = 100µA
Input capacitance	c_{iss}	2.3	2.8	3.5	pF	V_{DS} = 5V, V_{G1} = 5V
Output capacitance	c_{oss}	1.1	1.5	1.9	pF	V_{G2S} =4V, R_G = 82kΩ
Reverse transfer capacitance	c_{rss}	—	0.017	0.04	pF	f = 1MHz
Drain current	$I_{D(op)}$ 1	10	15	20	mA	V_{DS} = 5V, V_{G1} = 5V V_{G2S} = 4V, R_G = 82kΩ
	$I_{D(op)}$ 2	—	13	—	mA	V_{DS} = 9V, V_{G1} = 9V V_{G2S} =6V, R_G = 220kΩ
Forward transfer admittance	$|y_{fs}|$1	23	28	—	mS	V_{DS} = 5V, V_{G1} = 5V, V_{G2S} =4V R_G =82kΩ, f = 1kHz
	$|y_{fs}|$2	—	28	—	mS	V_{DS} = 9V, V_{G1} = 9V, V_{G2S} =6V R_G = 220kΩ, f = 1kHz
Power gain	PG1	24	28	—	dB	V_{DS} = 5V, V_{G1} = 5V, V_{G2S} =4V R_G = 82kΩ, f = 200MHz
	PG2	—	28	—	dB	V_{DS} = 9V, V_{G1} = 9V, V_{G2S} =6V R_G = 220kΩ, f = 200MHz
Noise figure	NF1	—	1.4	1.9	dB	V_{DS} = 5V, V_{G1} = 5V, V_{G2S} =4V R_G = 82kΩ, f = 200MHz
	NF2	—	1.4	—	dB	V_{DS} = 9V, V_{G1} = 9V, V_{G2S} =6V R_G = 220kΩ, f = 200MHz

Main Characteristics

Test Circuit for Operating Items ($I_{D(op)}$, |yfs|, Ciss, Coss, Crss, NF, PG)



Power Gain, Noise Figure Test Circuit



L1 : ϕ1mm Enameled Copper Wire,Inside dia 10mm, 2Turns
L2 : ϕ1mm Enameled Copper Wire,Inside dia 10mm, 2Turns
RFC : ϕ1mm Enameled Copper Wire,Inside dia 5mm, 2Turns

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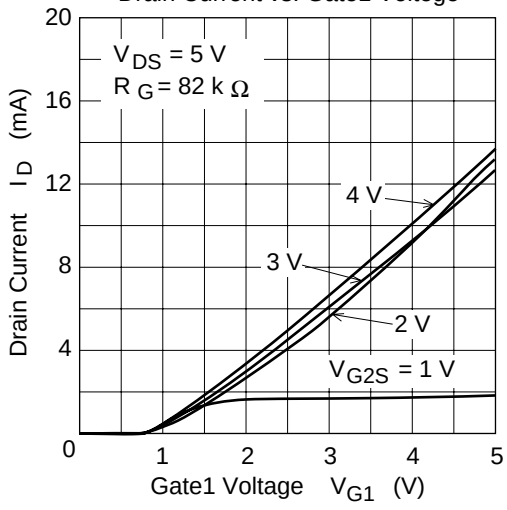
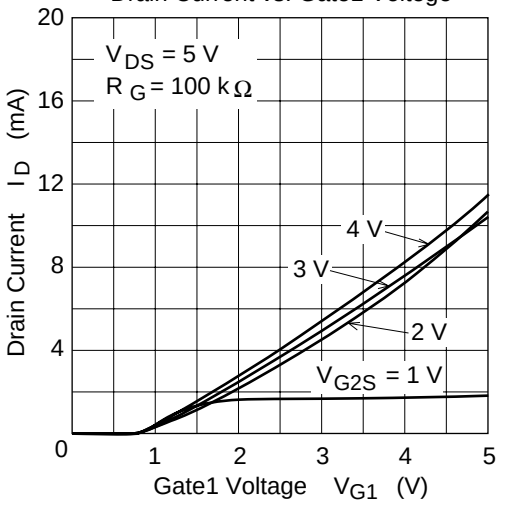
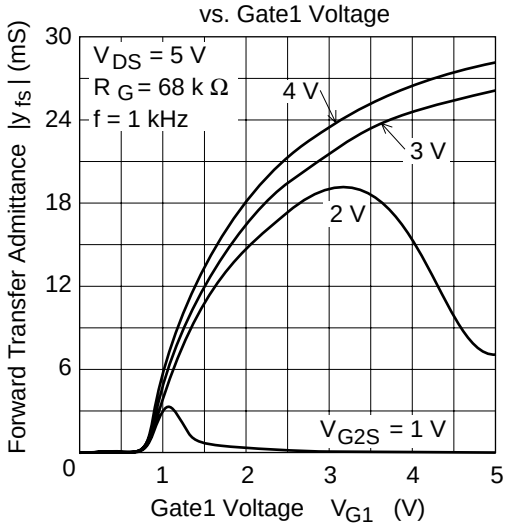
Drain Current vs. Gate1 Voltege



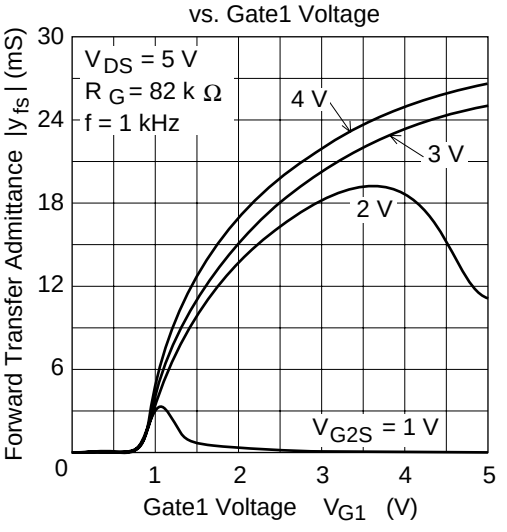
Drain Current vs. Gate1 Voltege



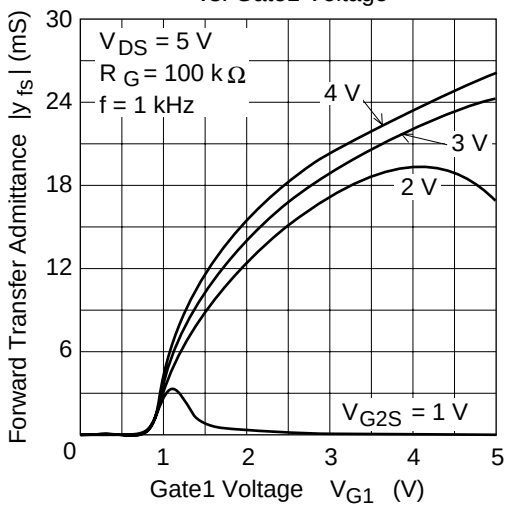
Forward Transfer Admittance vs. Gate1 Voltage



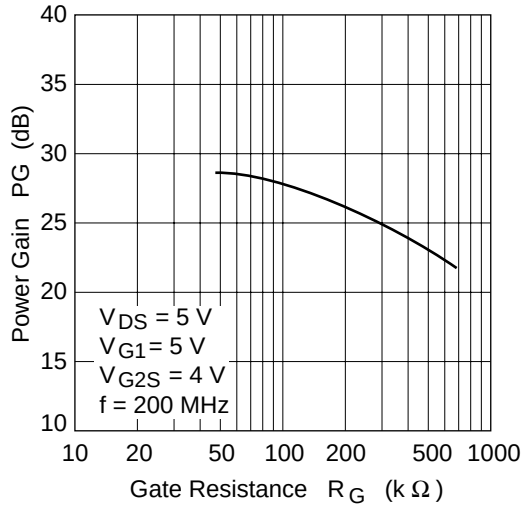
Forward Transfer Admittance vs. Gate1 Voltage



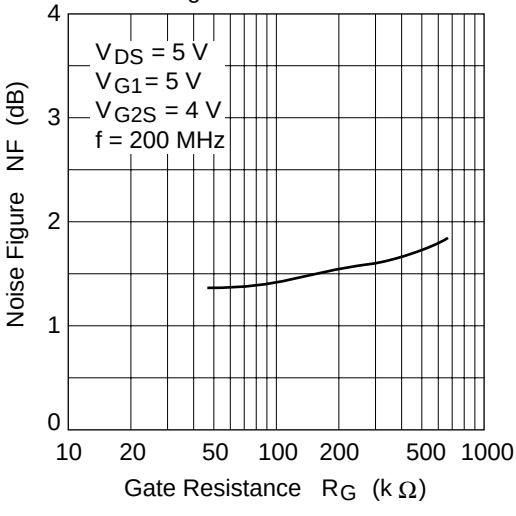
Forward Transfer Admittance vs. Gate1 Voltage



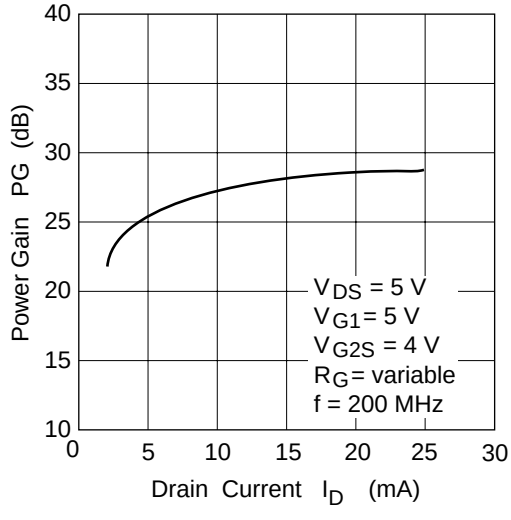
Power Gain vs. Gate Resistance



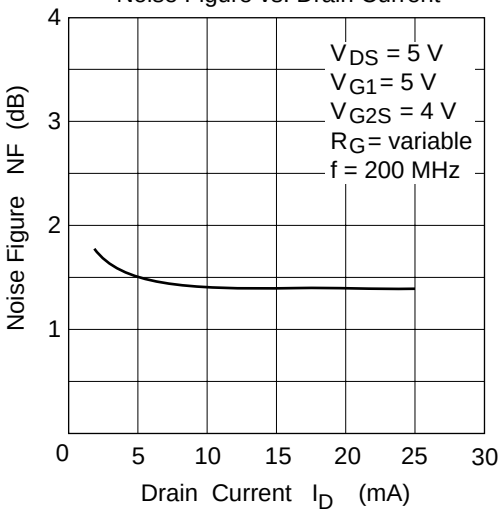
Noise Figure vs. Gate Resistance



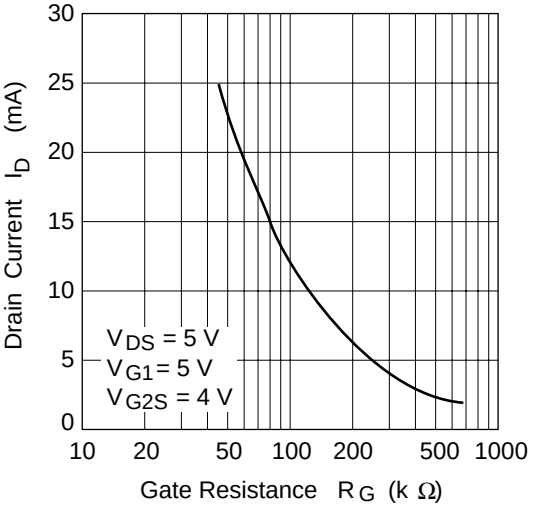
Power Gain vs. Drain Current



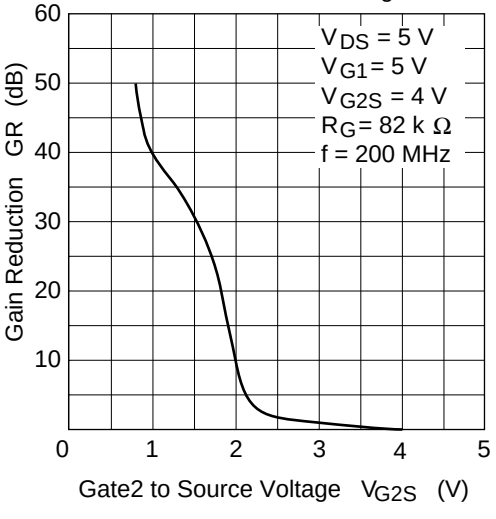
Noise Figure vs. Drain Current



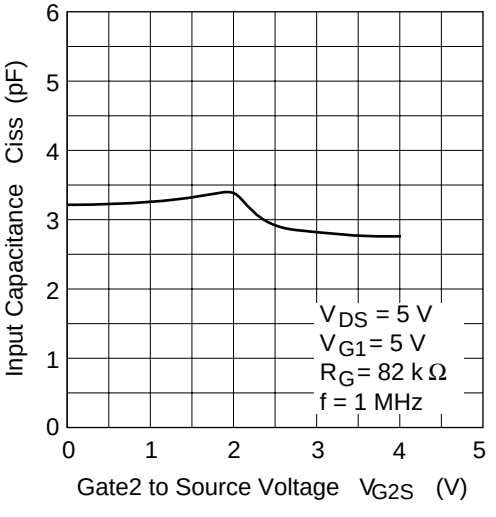
Drain Current vs. Gate Resistance



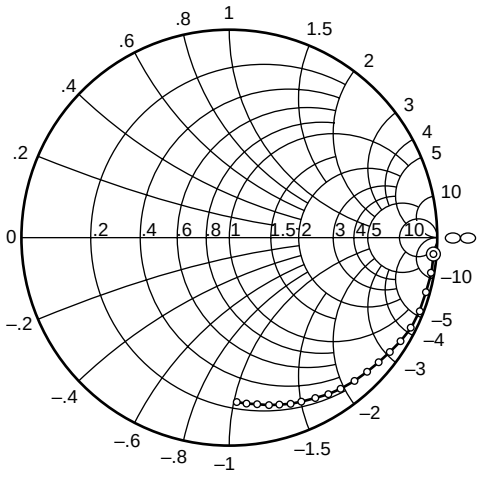
Gain Reduction vs.
Gate2 to Source Voltage



Input Capacitance vs.
Gate2 to Source Voltage

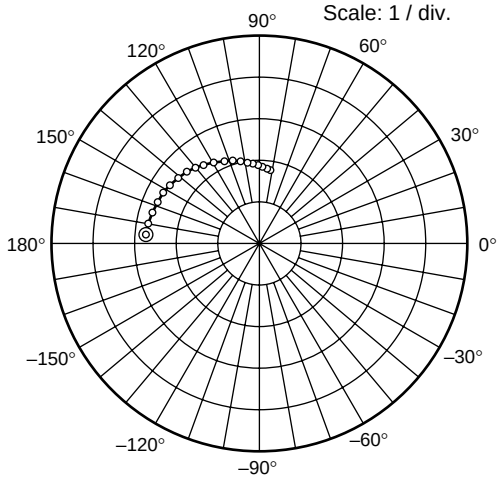


S11 Parameter vs. Frequency



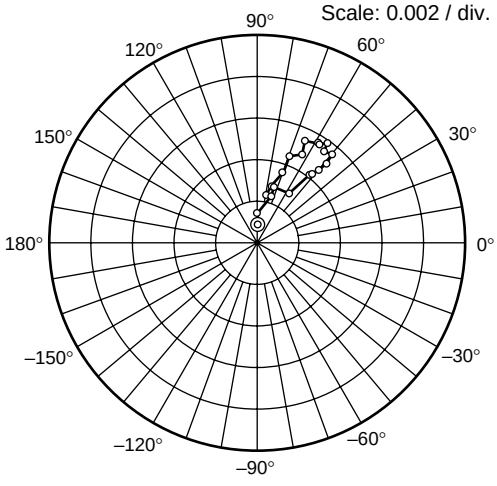
Test Condition : V_{DS}= 5 V , V_{G1}= 5 V
V_{G2S} = 4 V , R_G = 82 k Ω
50 to 1000 MHz (50 MHz step)

S21 Parameter vs. Frequency



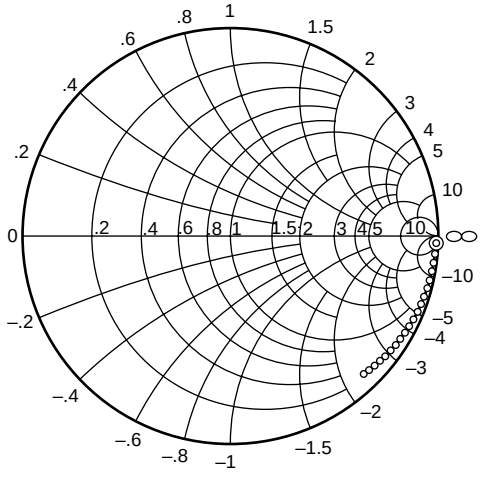
Test Condition : V_{DS}= 5 V , V_{G1}= 5 V
V_{G2S} = 4 V , R_G = 82 k Ω
50 to 1000 MHz (50 MHz step)

S12 Parameter vs. Frequency



Test Condition : V_{DS}= 5 V , V_{G1}= 5 V
V_{G2S} = 4 V , R_G = 82 k Ω
50 to 1000 MHz (50 MHz step)

S22 Parameter vs. Frequency



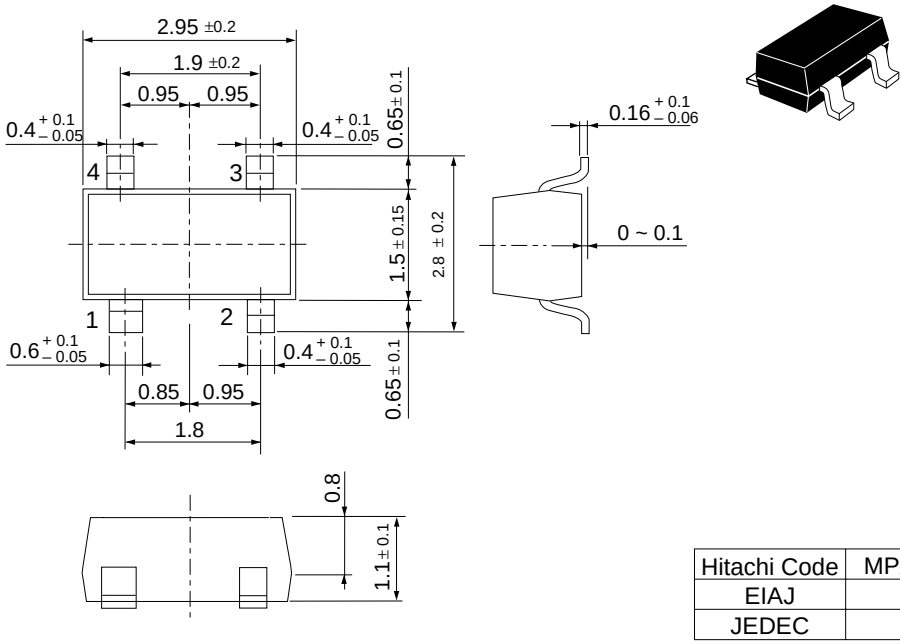
Test Condition : V_{DS}= 5 V , V_{G1}= 5 V
V_{G2S} = 4 V , R_G = 82 k Ω
50 to 1000 MHz (50 MHz step)

Sparameter (V_{DS} = V_{G1} = 5V, V_{G2S} = 4V, R_G = 82kΩ, Zo = 50Ω)

	S11		S21		S12		S22	
f (MHz)	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG
50	0.991	–4.8	2.69	174.9	0.00090	91.4	0.991	–2.2
100	0.991	–9.9	2.68	169.3	0.00153	90.5	0.992	–4.8
150	0.982	–15.4	2.66	163.4	0.00243	73.8	0.991	–7.5
200	0.975	–20.7	2.62	157.5	0.00293	74.9	0.989	–9.9
250	0.972	–25.6	2.60	152.0	0.00370	70.1	0.985	–12.6
300	0.956	–30.6	2.54	146.3	0.00444	69.0	0.981	–15.0
350	0.942	–35.5	2.47	140.9	0.00478	63.7	0.977	–17.3
400	0.928	–40.1	2.42	135.7	0.00535	64.8	0.973	–19.7
450	0.920	–44.9	2.38	130.5	0.00551	56.8	0.967	–22.0
500	0.906	–49.2	2.32	125.7	0.00549	58.6	0.962	–24.5
550	0.894	–53.6	2.25	120.8	0.00584	54.4	0.957	–26.9
600	0.880	–57.8	2.18	116.2	0.00542	53.3	0.952	–29.2
650	0.868	–62.1	2.12	111.5	0.00562	49.5	0.944	–31.5
700	0.854	–66.2	2.06	106.8	0.00509	48.6	0.939	–33.8
750	0.842	–70.3	2.00	102.5	0.00465	49.7	0.933	–36.1
800	0.835	–73.9	1.94	98.4	0.00427	51.6	0.927	–38.3
850	0.820	–77.7	1.89	94.0	0.00416	53.3	0.921	–40.5
900	0.802	–81.5	1.83	89.6	0.00289	57.9	0.915	–42.7
950	0.801	–84.7	1.78	85.6	0.00288	72.9	0.909	–44.9
1000	0.789	–87.9	1.73	82.1	0.00241	78.9	0.904	–47.1

Package Dimensions

Unit: mm



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